



FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)								ATTY. DOCKET NO. SHP-PT077		SERIAL NO. 10/612,133				
								APPLICANT Miles et al.						
								FILING DATE June 2, 2003		GROUP 2878				
U.S. PATENT DOCUMENTS														
EXAMINER INITIAL		DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
DXL	AA	5	7	4	2	1	7	2	04/1998		324	754		
DXL	AB	6	1	7	2	5	0	6	01/2001		324	458		
FOREIGN PATENT DOCUMENTS														
		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
DXL	AC	0	4	1	0	1	3	1	01/1991	Europe			YES	NO
DXL	AD	0	5	5	1	8	1	4	07/1993	Europe				
DXL	AE	8	1	2	9	0	1	8	05/1996	Japan				
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)														
EXAMINER								DATE CONSIDERED						
<i>[Signature]</i>								08/16/05						

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Sheet 1 of 1

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
DXL	AF	6,008,489	12/1999	Elings et al.	250	234	
DXL	AG	6,220,084	04/2001	Chen et al.	73	105	
DXL	AH	6,404,207	06/2002	Bhushan	324	671	
DXL	AI	2002/0097046	07/2002	Kitamura	324	244	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES <input type="checkbox"/> NO <input type="checkbox"/>
DXL	AJ	WO 02/063368	08/2002	PCT			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
DXL	AK	Tran et al., "Zepotofarad (10-21F) Resolution Capacitance Sensor for Scanning Capacitance Microscopy," American Institute of Physics, June 2001 (2001-06), Vol. 72, no. 6, pages 2618-2623					
EXAMINER		DATE CONSIDERED 08/16/05					

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